# **PCA2002**

# 32 kHz watch circuit with programmable output period and pulse width

Rev. 9 — 6 December 2019

**Product data sheet** 

# 1. General description

The PCA2002 is a CMOS¹ integrated circuit for battery operated wrist watches with a 32 kHz quartz crystal as the timing element and a bipolar stepping motor. The quartz crystal oscillator and the frequency divider are optimized for minimum current consumption. A timing accuracy of 1 ppm is achieved with a programmable, digital frequency adjustment.

The output period and the output pulse width can be programmed. It can be selected between a full output pulse or a chopped output pulse with a duty cycle of 75 %. In addition, a stretching pulse can be added to the primary driving pulse.

A pad RESET is provided (used for stopping the motor) for accurate time setting and for accelerated testing of the watch.

### 2. Features and benefits

- Amplitude-regulated 32 kHz quartz crystal oscillator, with excellent frequency stability and high immunity to leakage currents
- Electrically programmable time calibration with 1 ppm resolution stored in One Time Programmable (OTP) memory
- The quartz crystal is the only external component required
- Very low current consumption: typically 90 nA
- Output pulses for bipolar stepping motors
- Five different programmable output periods (1 s to 30 s)
- Output pulse width programmable between 1 ms and 8 ms
- Full or chopped motor pulse and pulse stretching, selectable
- Stop function for accurate time setting and current saving during shelf life
- Test mode for accelerated testing of the mechanical parts of the watch
- Test bits for type recognition

# 3. Applications

- Driver circuits for bipolar stepping motors
- High immunity motor drive circuits
- High production volumes

<sup>1.</sup> The definition of the abbreviations and acronyms used in this data sheet can be found in Section 14.



### 32 kHz watch circuit with programmable output period and pulse width

# 4. Ordering information

Table 1. Ordering information

Type number	Topside	Package						
	marking[1]	Name	Description	Version				
PCA2002U/AB/1	PC 2002-1	wire bond die	8 bonding pads; 1.16 × 0.86 × 0.22 mm	PCA200xU				
PCA2002U/10AB/1	PC 2002-1	wire bond die	8 bonding pads; $1.16 \times 0.86 \times 0.22$ mm	PCA200xU				
PCA2002DUS/DA	PC 2002-1	WLCSP8	wafer level chip-size package; 8 bumps; 1.16 mm x 0.86 mm	SOT1455-1				

<sup>[1]</sup> Marking "PC2002-1" on active side of die

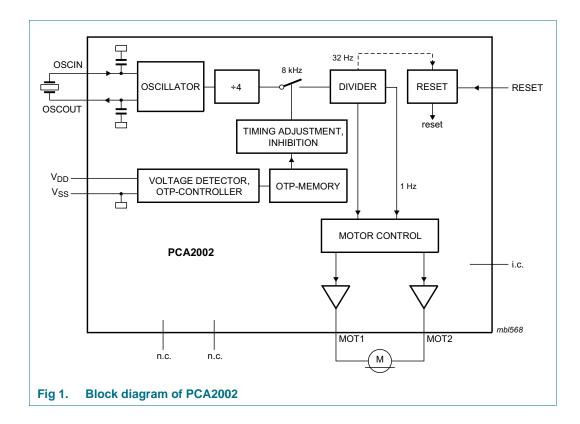
# 4.1 Ordering options

Table 2. Ordering options

Type number	Orderable part number	Package	<b>g</b>	Minimum order quantity	Temperature
PCA2002U/AB/1	PCA2002U/AB/1,026	wire bond die	bare die; chip in tray	36000	$T_{amb} = -10  ^{\circ}\text{C} \text{ to } +60  ^{\circ}\text{C}$
PCA2002U/10AB/1	PCA2002U/10AB/1,00	wire bond die	sawn wafer on Film Frame Carrier (FFC), see <u>Figure 17</u>	45192	$T_{amb} = -10 ^{\circ}\text{C} \text{ to } +60 ^{\circ}\text{C}$
PCA2002DUS/DA	PCA2002DUS/DAZ	WLCSP8	Reel 7" Q1 in tape reel dry pack	4000	$T_{amb} = -10  ^{\circ}\text{C} \text{ to } +60  ^{\circ}\text{C}$

32 kHz watch circuit with programmable output period and pulse width

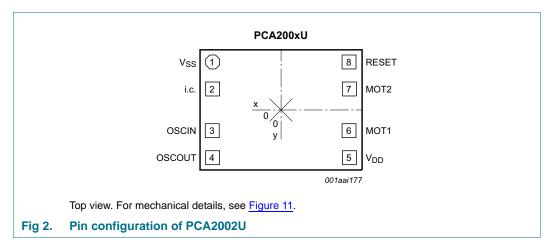
# 5. Block diagram

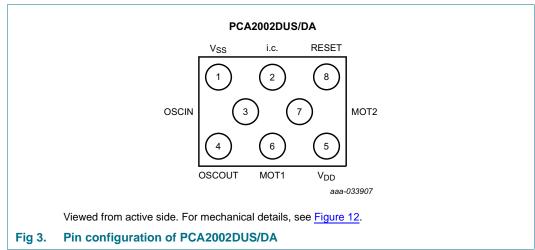


32 kHz watch circuit with programmable output period and pulse width

# 6. Pinning information

# 6.1 Pinning





### 32 kHz watch circuit with programmable output period and pulse width

# 6.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
V <sub>SS</sub> [1]	1	ground
i.c.[2]	2	internally connected
OSCIN	3	oscillator input
OSCOUT	4	oscillator output
$V_{DD}$	5	supply voltage
MOT1	6	motor 1 output
MOT2	7	motor 2 output
RESET	8	reset input

<sup>[1]</sup> The substrate (rear side of the chip) is connected to  $V_{SS}$ . Therefore the die pad must be either floating or connected to  $V_{SS}$ .

<sup>[2]</sup> Pad i.c. is used for factory tests; in normal operation it should be left open-circuit, and it has an internal pull-down resistance to  $V_{SS}$ .

32 kHz watch circuit with programmable output period and pulse width

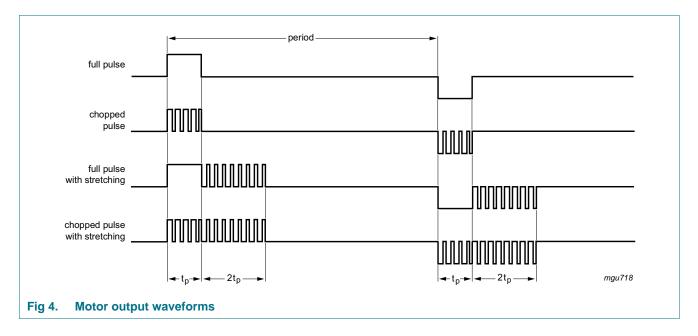
# 7. Functional description

### 7.1 Motor pulse

The motor driver delivers pulses with an alternating polarity. The output waveform across the motor terminals is illustrated in <u>Figure 4</u>. Between the motor pulses, both terminals are connected to  $V_{DD}$ , which means that the motor is short-circuit.

The following parameters can be selected and are stored in a One Time Programmable (OTP) memory:

- Output periods of 1 s, 5 s, 10 s, 20 s and 30 s
- Pulse width (t<sub>n</sub>) between 0.98 ms and 7.8 ms in steps of 0.98 ms
- Full or chopped (75 %) output pulse
- Pulse stretching: an enlargement pulse is added to the primary motor pulse. This
  enlargement pulse has a duty cycle of 25 % and a width, which is twice the
  programmed motor pulse width.



### 7.2 Time calibration

The quartz crystal oscillator has an integrated capacitance of 5.2 pF, which is lower than the specified capacitance ( $C_L$ ) of 8.2 pF for the quartz crystal (see <u>Table 10</u>). Therefore, the oscillator frequency is typically 60 ppm higher than 32.768 kHz. This positive frequency offset is compensated by removing the appropriate number of 8192 Hz pulses in the divider chain (maximum 127 pulses), every 1 or 2 minutes. The time correction is given in <u>Table 4</u>.

### 32 kHz watch circuit with programmable output period and pulse width

Table 4. Time calibration

Calibration period	Correction per sto	ep (n = 1)	Correction per step (n = 127)		
	ppm	seconds per day	ppm	seconds per day	
1 minute	2.03	0.176	258	22.3	
2 minutes	1.017	0.088	129	11.15	

After measuring the effective oscillator frequency, the number of correction pulses must be calculated and stored together with the calibration period in the OTP memory (see Section 7.6).

The oscillator frequency can be measured at pad RESET, where a square wave signal with the frequency of  $\frac{l}{1024} \times f_{osc}$  is provided.

This frequency shows a jitter every minute or every two minutes, depending on the programmed calibration period, which originates from the time calibration.

Details on how to measure the oscillator frequency and the programmed inhibition time are given in <u>Section 7.10</u>.

### 7.3 Reset

At pin RESET an output signal with a frequency of  $\frac{1}{1024} \times f_{osc} = 32Hz$  is provided.

Connecting pin RESET to V<sub>DD</sub> stops the motor drive and opens the motor switches.

After releasing pin RESET, the first motor pulse is generated exactly one period later with the opposite polarity to the last pulse before stopping. The debounce time for the reset function is between 31 ms and 62 ms.

Connecting pin RESET to  $V_{SS}$  activates the test mode. In this mode the motor output frequency is 32 Hz, which can be used to test the mechanical function of the watch.

# 7.4 Programming possibilities

The programming data is organized in an array of 8-bit words (see <u>Table 5</u>): Word A contains the time calibration, word B the setting for the monitor pulses, word C is not used and word D contains the type recognition.

Table 5. Words and bits

Word	Bit								
	1	2	3	4	5	6	7	8	
Α	number of 8192 Hz pulses to be removed calibration period								
В	pulse width			output per	iod		duty cycle	pulse stretching	
С									
D	type factory test bit								

### 32 kHz watch circuit with programmable output period and pulse width

Table 6. Description of word A bits

Bit	Value	Description
Inhibit time		
1 to 7	-	adjust the number of the 8192 Hz pulses to be removed; bit 1 is the MSB and bit 7 is the LSB
Calibration period	d	
8	0	1 minute
	1	2 minutes

Table 7. Description of word B bits

	Description of word	
Bit	Value	Description
Pulse width	t <sub>p</sub> (ms)	
1 to 3	000	0.98
	001	1.95
	010	2.9
	011	3.9
	100	4.9
	101	5.9
	110	6.8
	111	7.8
Output perio	od (s)	
4 to 6	000	1
	001	5
	010	10
	011	20
	100	30
Duty cycle o	of motor pulse	
7	0	75 %
	1	100 %
Pulse stretc	hing	
8	0	no pulse stretching
	1	a pulse width of $2 \times t_p$ and a duty factor of 25 % are added

# 7.5 Type recognition

Byte D is read to determine, which type of the PCA200x family is used in a particular application.

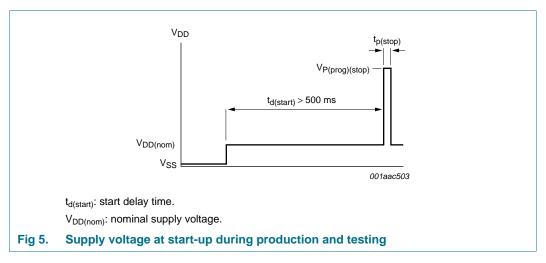
Table 8. Description of word D bits

Bit	Value	Description
Type recognition		
1 to 4	0000	PCA2002
	1000	PCA2000
	0100	PCA2001
	1100	PCA2003

#### 32 kHz watch circuit with programmable output period and pulse width

### 7.6 Programming procedure

To ensure that the oscillator starts up correctly you must execute a reset sequence (see Figure 5).



For a watch it is essential that the timing calibration can be made after the watch is fully assembled. In this situation, the supply pins are often the only terminals which are still accessible.

Writing to the OTP cells and performing the related functional checks is achieved in the PCA2002 by modulating the supply voltage. The necessary control circuit consists basically of a voltage level detector, an instruction counter, which determines the function to be performed, and an 8-bit shift register, which allows writing the OTP cells of an 8-bit word in one step and which acts as data pointer for checking the OTP content.

- State 1; measurement of the crystal oscillator frequency (divided by 1024)
- State 2; measurement of the inhibition time
- State 3; write/check word A
- State 4; write/check word B
- State 5; check word C (don't care since no meaning)
- State 6; check word D (type recognition)

Each instruction state is switched on with a pulse to  $V_{P(prog)(start)}$ . After this large pulse, an initial waiting time of  $t_0$  is required. The programming instructions are then entered by modulating the supply voltage with small pulses (amplitude  $V_{P(mod)}$  and pulse width  $t_{mod}$ ). The first small pulse defines the start time, the following pulses perform three different functions, depending on the time delay ( $t_d$ ) from the preceding pulse (see <u>Figure 6</u>, <u>Figure 7</u>, <u>Figure 8</u>, <u>Figure 9</u> and <u>Figure 10</u>):

- $t_d = t_1$  (0.7 ms); increments the instruction counter
- t<sub>d</sub> = t<sub>2</sub> (1.7 ms); clocks the shift register with data = logic 0
- t<sub>d</sub> = t<sub>3</sub> (2.7 ms); clocks the shift register with data = logic 1

The programming procedure requires a stable oscillator, which means that a waiting time, determined by the start-up time of the oscillator, is necessary after power-up of the circuit.

### 32 kHz watch circuit with programmable output period and pulse width

After the  $V_{P(prog)(start)}$  pulse, the instruction counter is in state 1 and the data shift register is cleared.

The instruction state ends with a second pulse to  $V_{P(prog)(stop)}$  or with the pulse to  $V_{store}$ .

In any case, the instruction states are terminated automatically 2 seconds after the last supply modulation pulse.

### 7.7 Programming the memory cells

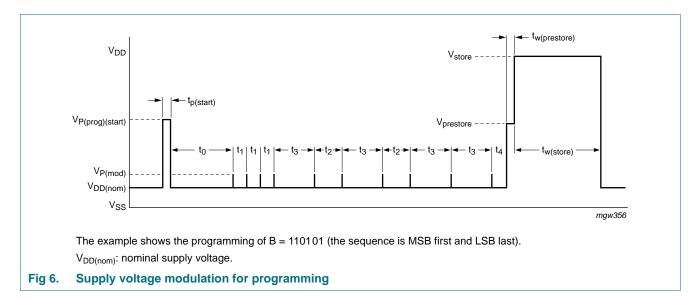
Applying the two-stage programming pulse (see <u>Figure 6</u>) transfers the stored data in the shift register to the OTP cells.

Perform the following to program a memory word:

- 1. Starting with a V<sub>P(prog)(start)</sub> pulse, wait for the time period t<sub>0</sub> then set the instruction counter to the word to be written (t<sub>d</sub> = t<sub>1</sub>).
- 2. Enter the data to be stored into the shift register (t<sub>d</sub> = t<sub>2</sub> or t<sub>3</sub>), LSB first (bit 8) and MSB last (bit 1).
- 3. Applying the two-stage programming pulse  $V_{prestore}$  followed by  $V_{store}$  stores the word. The delay between the last data bit and the pre-store pulse  $V_{prestore}$  is  $t_d = t_4$ . Store the word by raising the supply voltage to  $V_{store}$ ; the delay between the last data bit and the store pulse is  $t_d$ .

The example shown in Figure 6 performs the following functions:

- Start
- Setting the instruction counter to state 4 (word B)
- Entering data word 110101 into the shift register (sequence: LSB first and MSB last)
- Writing the OTP cells for word B



### 32 kHz watch circuit with programmable output period and pulse width

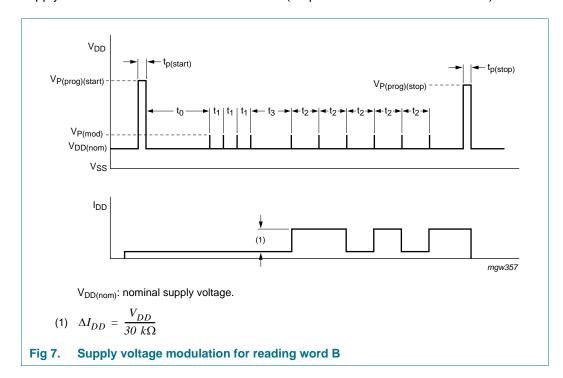
### 7.8 Checking the memory content

The stored data of the OTP array can be checked bit wise by measuring the supply current (see <u>Figure 7</u>). The array word is selected by the instruction state and the bit is addressed by the shift register.

To read a word, the word is first selected ( $t_d = t_1$ ) and a logic 1 is written into the first cell of the shift register ( $t_d = t_3$ ). This logic 1 is then shifted through the entire shift register ( $t_d = t_2$ ), so that it points with each clock pulse to the next bit.

If the addressed OTP cell contains a logic 1, a 30 k $\Omega$  resistor is connected between V<sub>DD</sub> and V<sub>SS</sub>; this increases the supply current accordingly.

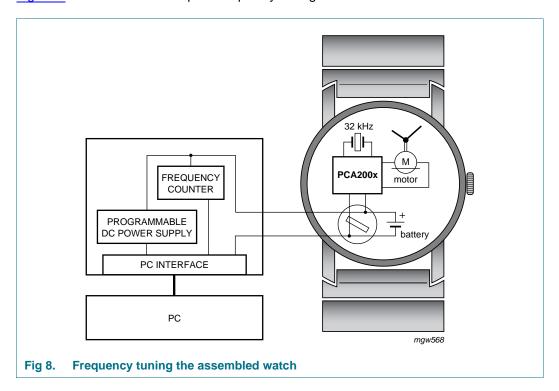
<u>Figure 7</u> shows the supply voltage modulation for reading word B, with the corresponding supply current variation for word B = 110101 (sequence: first MSB and last LSB).



### 32 kHz watch circuit with programmable output period and pulse width

### 7.9 Frequency tuning at assembled watch

Figure 8 shows the test set-up for frequency tuning the assembled watch.



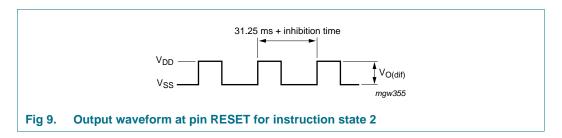
### 7.10 Measurement of the oscillator frequency and the inhibition time

The output of the two measuring states can either be monitored directly at pin RESET or as a modulation of the supply current (a modulating resistor of 30 k $\Omega$  is connected between V<sub>DD</sub> and V<sub>SS</sub> when the signal at pin RESET is at HIGH-level).

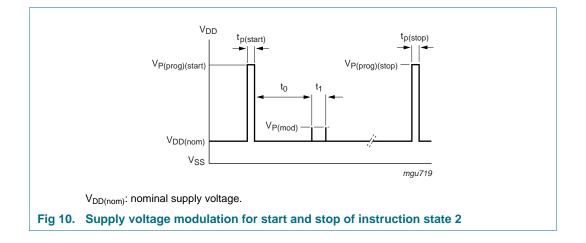
The supply voltage modulation must be followed as shown in <u>Figure 5</u> in order to guarantee the correct start-up of the circuit during production and testing.

#### Measuring states:

- State 1; quartz crystal oscillator frequency divided by 1024; state 1 starts with a pulse to V<sub>P</sub> and ends with a second pulse to V<sub>P</sub>
- State 2; inhibition time has a value of n × 0.122 ms. A signal with the periodicity of 31.25 ms + n × 0.122 ms appears at pin RESET and as current modulation at pin V<sub>DD</sub> (see Figure 9 and Figure 10)



### 32 kHz watch circuit with programmable output period and pulse width



### 32 kHz watch circuit with programmable output period and pulse width

# 8. Limiting values

Table 9. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{DD}$	supply voltage	$V_{SS} = 0 V$	[1][2]	-1.8	+7.0	V
$V_{I}$	input voltage			-0.5	+7.5	V
t <sub>sc</sub>	short circuit duration time	output		-	indefinite	S
$V_{ESD}$	electrostatic discharge voltage	HBM	[3]	-	±2000	V
		MM	<u>[4]</u>	-	±200	V
I <sub>Iu</sub>	latch-up current		<u>[5]</u>	-	100	mΑ
T <sub>stg</sub>	storage temperature		[6]	-30	+100	°C
T <sub>amb</sub>	ambient temperature			-10	+60	°C

- [1] When writing to the OTP cells, the supply voltage (VDD) can be raised to a maximum of 12 V for a time period of 1 s.
  - [2] Connecting the battery with reversed polarity does not destroy the circuit, but in this condition a large current flows which rapidly discharges the battery.
  - [3] Pass level; Human Body Model (HBM), according to Ref. 6 "JESD22-A114".
  - [4] Pass level; Machine Model (MM), according to Ref. 7 "JESD22-A115".
- [5] Pass level; latch-up testing according to Ref. 8 "JESD78" at maximum ambient temperature (T<sub>amb(max)</sub>).
- [6] According to the NXP store and transport requirements (see Ref. 10 "NX3-00092") the devices have to be stored at a temperature of +8 °C to +45 °C and a humidity of 25 % to 75 %. For long term storage products deviant conditions are described in that document.

### 32 kHz watch circuit with programmable output period and pulse width

### 9. Characteristics

Table 10. Characteristics

 $V_{DD}$  = 1.55 V;  $V_{SS}$  = 0 V;  $f_{osc}$  = 32.768 kHz;  $T_{amb}$  = 25 °C; quartz crystal:  $R_s$  = 40 k $\Omega$ ,  $C_1$  = 2 fF to 3 fF,  $C_L$  = 8.2 pF; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Supplies						
$V_{DD}$	supply voltage	normal operating mode; $T_{amb} = -10 \text{ °C to } +60 \text{ °C}$	1.1	1.55	3.6	V
$\Delta V_{DD}$	supply voltage variation	$\Delta V/\Delta t = 1 V/\mu s$	-	-	0.25	V
I <sub>DD</sub>	supply current	between motor pulses	-	90	120	nA
		between motor pulses at V <sub>DD</sub> = 3.5 V	-	120	180	nA
		$T_{amb} = -10  ^{\circ}\text{C} \text{ to } +60  ^{\circ}\text{C}$	-	-	200	nA
		stop mode; pin RESET connected to $V_{DD}$	-	100	135	nA
Motor out	put					
V <sub>sat</sub>	saturation voltage	$R_{\text{motor}} = 2 \text{ k}\Omega;$ $T_{\text{amb}} = -10 \text{ °C to +60 °C}$	-	150	200	mV
$Z_{o(sc)}$	output impedance (short circuit)	between motor pulses; I <sub>motor</sub> < 1 mA	-	200	300	Ω
Oscillator						
V <sub>start</sub>	start voltage		1.1	-	-	V
g <sub>m</sub>	transconductance	$V_{i(osc)} \leq 50 \ mV(p\text{-}p)$	5	10	-	μS
t <sub>startup</sub>	start-up time		-	0.3	0.9	S
∆f/f	frequency stability	$\Delta V_{DD} = 100 \text{ mV}$	-	0.05	0.2	ppm
$C_{L(itg)}$	integrated load capacitance		4.3	5.2	6.3	pF
R <sub>par</sub>	parasitic resistance	allowed resistance between adjacent pins	20	-	-	МΩ
Pad RESE	T					
f <sub>o</sub>	output frequency		-	32	-	Hz
$V_{O(dif)}$	differential output voltage	$R_L = 1 \text{ M}\Omega; C_L = 10 \text{ pF}$	1.4	-	-	V
t <sub>r</sub>	rise time	$R_L = 1 \text{ M}\Omega$ ; $C_L = 10 \text{ pF}$	<u>[1]</u> -	1	-	μS
t <sub>f</sub>	fall time	$R_L = 1 \text{ M}\Omega; C_L = 10 \text{ pF}$	<u>[1]</u> -	1	-	μS
$I_{i(AV)}$	average input current	pin RESET connected to $V_{DD}$ or $V_{SS}$	-	10	20	nA

<sup>[1]</sup>  $R_L$  and  $C_L$  are a load resistor and load capacitor, externally connected to pad RESET.

### 32 kHz watch circuit with programmable output period and pulse width

# 10. OTP programming characteristics

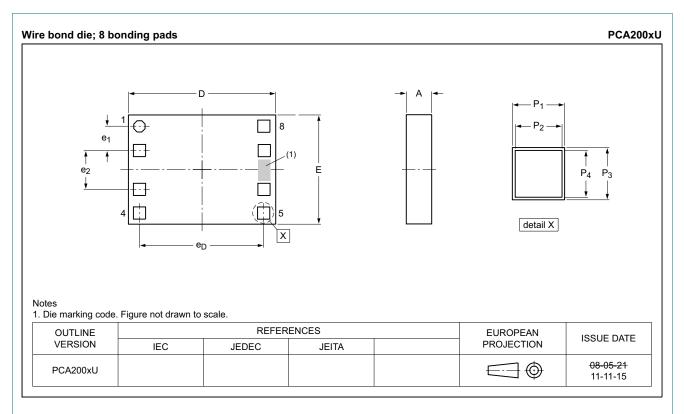
Table 11. Specifications for OTP programming

Symbol	Parameter <sup>[1]</sup>	Conditions	Min	Тур	Max	Unit
$V_{DD}$	supply voltage	during programming procedure	1.5	-	3.0	V
V <sub>P(prog)(start)</sub>	programming supply voltage (start)		6.6	-	6.8	V
V <sub>P(prog)(stop)</sub>	programming supply voltage (stop)		6.2	-	6.4	V
$V_{P(mod)}$	supply voltage modulation	for entering instructions, referred to $V_{\text{DD}}$	320	350	380	mV
V <sub>prestore</sub>	prestore voltage	for prestore pulse	6.2	-	6.4	V
V <sub>store</sub>	supply voltage	for writing to the OTP cells	9.9	10.0	10.1	V
I <sub>store</sub>	store current	for writing to the OTP cells	-	-	10	mΑ
t <sub>p(start)</sub>	start pulse width		8	10	12	ms
t <sub>p(stop)</sub>	pulse width of stop pulse		0.05	-	0.5	ms
t <sub>mod</sub>	modulation pulse width		25	30	40	μS
t <sub>w(prestore)</sub>	prestore pulse width		0.05	-	0.5	ms
t <sub>w(store)</sub>	store pulse width	for writing to the OTP cells	95	100	110	ms
$t_0$	time 0	waiting time after start pulse	20	-	30	ms
t <sub>1</sub>	time 1	pulse distance for incrementing the state counter	0.6	0.7	8.0	ms
t <sub>2</sub>	time 2	pulse distance for clocking the data register with data = logic 0	1.6	1.7	1.8	ms
t <sub>3</sub>	time 3	pulse distance for clocking the data register with data = logic 1	2.6	2.7	2.8	ms
t <sub>4</sub>	time 4	waiting time for writing to OTP cells	0.1	0.2	0.3	ms
SR	slew rate	for modulation of the supply voltage	0.5	-	5.0	V/μs
R <sub>mod</sub>	modulation resistance	supply current modulation read-out resistor	18	30	45	kΩ

<sup>[1]</sup> Program each word once only.

### 32 kHz watch circuit with programmable output period and pulse width

# 11. Bare die outline



(1) Marking code PC2002-1

Fig 11. Bare die outline of PCA2002U

Table 12. Dimensions of PCA2002U

Original dimensions are in mm.

Unit (mm)	Α	D	E	<b>e</b> <sub>1</sub>	$e_2$	$\mathbf{e}_{D}$	P <sub>1</sub>	$P_2$	$P_3$	$P_4$
max	0.22	-	-	-	-	-	0.099	0.089	0.099	0.089
nom	0.20	1.16	0.86	0.17	0.32	0.96	0.096	0.086	0.096	0.086
min	0.18	-	-	-	-	-	0.093	0.083	0.093	0.083

### 32 kHz watch circuit with programmable output period and pulse width

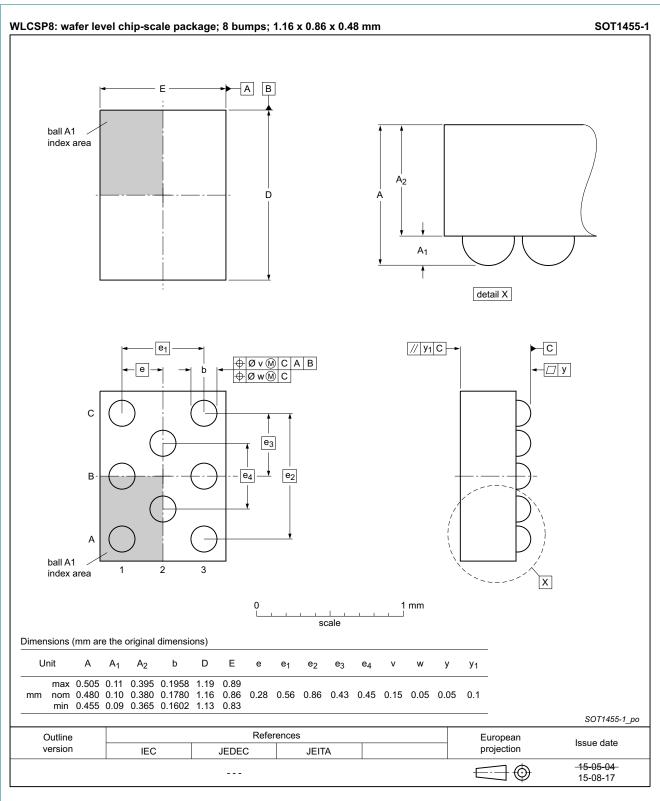


Fig 12. Package outline SOT1455-1 (WLCSP8)

32 kHz watch circuit with programmable output period and pulse width

# 12. Packing information

# 12.1 Tape and reel information

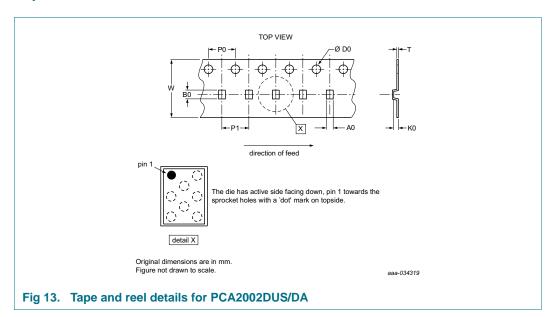


Table 13. Carrier tape dimensions of PCA2002DUS/DA

Nominal values with production tolerances.

Symbol	Description	Value	Unit	
Compartments				
A0	pocket width in x direction	$1.00 \pm 0.05$	mm	
В0	pocket width in y direction	$1.30 \pm 0.05$	mm	
K0	pocket depth	$0.62 \pm 0.05$	mm	
Overall dimensions				
W	tape width	8	mm	
Т	tape thickness	$0.2 \pm 0.02$	mm	
D0	sprocket hole diameter	1.5	mm	
P0	sprocket hole pitch	4 ± 0.1	mm	
P1	pocket pitch	4 ± 0.1	mm	

# 32 kHz watch circuit with programmable output period and pulse width

# 12.2 Tray information

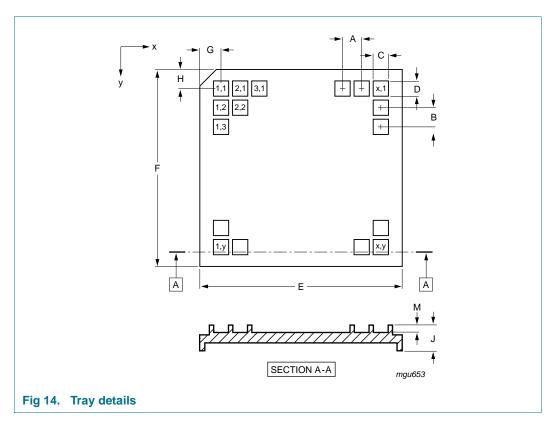
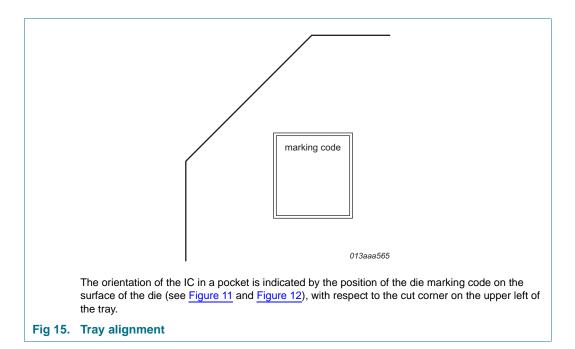


Table 14. Tray dimensions

•		
Dimension	Description	Value
Α	pocket pitch; x direction	2.15 mm
В	pocket pitch; y direction	2.43 mm
С	pocket width; x direction	1.01 mm
D	pocket width; y direction	1.39 mm
E	tray width; x direction	50.67 mm
F	tray width; y direction	50.67 mm
G	distance from cut corner to pocket (1 and 1) center	4.86 mm
Н	distance from cut corner to pocket (1 and 1) center	4.66 mm
J	tray thickness	3.94 mm
M	pocket depth	0.61 mm
X	number of pockets in x direction	20
у	number of pockets in y direction	18

### 32 kHz watch circuit with programmable output period and pulse width



### 32 kHz watch circuit with programmable output period and pulse width

# 12.3 Wafer and Film Frame Carrier (FFC) information

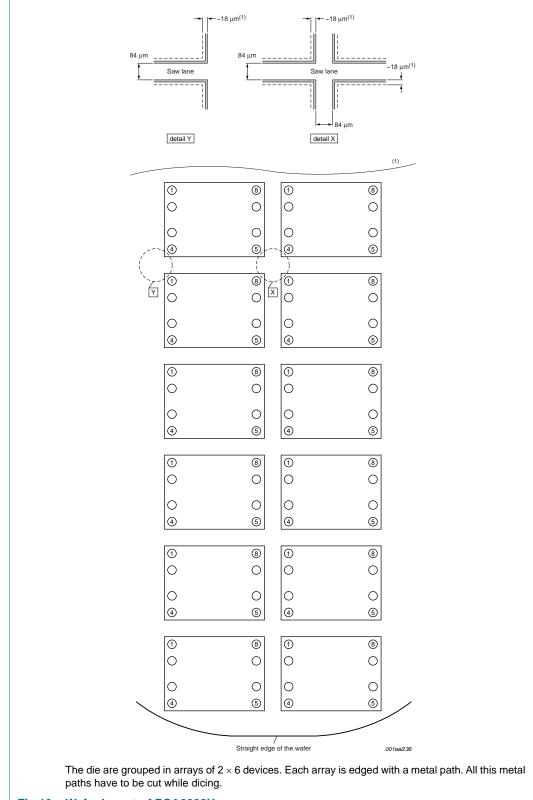


Fig 16. Wafer layout of PCA2002U

### 32 kHz watch circuit with programmable output period and pulse width

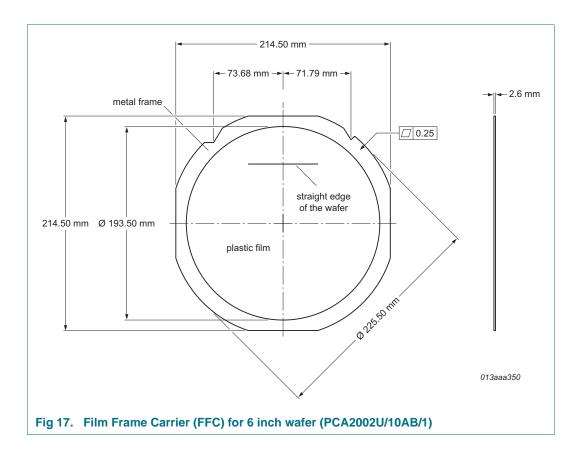


Table 15. PCA2002 wafer information

Type number	Wafer thickness	Wafer diameter	FFC for wafer size	Marking of bad die
PCA2002U/10AB/1	0.20 mm	6 inch	6 inch	wafer mapping

32 kHz watch circuit with programmable output period and pulse width

# 13. Soldering of WLCSP packages

### 13.1 Introduction to soldering WLCSP packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering WLCSP (Wafer Level Chip-Size Packages) can be found in application note AN10439 "Wafer Level Chip Scale Package" and in application note AN10365 "Surface mount reflow soldering description".

Wave soldering is not suitable for this package.

All NXP WLCSP packages are lead-free.

### 13.2 Board mounting

Board mounting of a WLCSP requires several steps:

- 1. Solder paste printing on the PCB
- 2. Component placement with a pick and place machine
- 3. The reflow soldering itself

### 13.3 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 18</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues, such as smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature), and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic) while being low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 16.

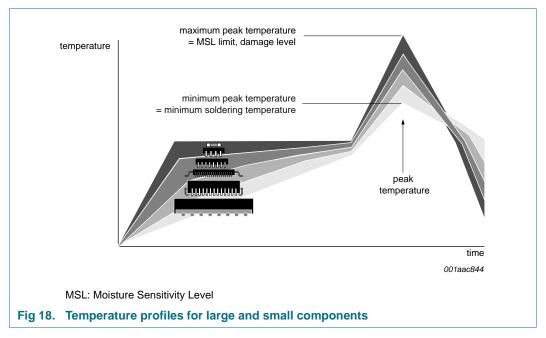
Table 16. Lead-free process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)			
	Volume (mm³)			
	< 350	350 to 2000	> 2000	
< 1.6	260	260	260	
1.6 to 2.5	260	250	245	
> 2.5	250	245	245	

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 18.

### 32 kHz watch circuit with programmable output period and pulse width



For further information on temperature profiles, refer to application note *AN10365* "Surface mount reflow soldering description".

#### 13.3.1 Stand off

The stand off between the substrate and the chip is determined by:

- The amount of printed solder on the substrate
- The size of the solder land on the substrate
- The bump height on the chip

The higher the stand off, the better the stresses are released due to TEC (Thermal Expansion Coefficient) differences between substrate and chip.

### 13.3.2 Quality of solder joint

A flip-chip joint is considered to be a good joint when the entire solder land has been wetted by the solder from the bump. The surface of the joint should be smooth and the shape symmetrical. The soldered joints on a chip should be uniform. Voids in the bumps after reflow can occur during the reflow process in bumps with high ratio of bump diameter to bump height, i.e. low bumps with large diameter. No failures have been found to be related to these voids. Solder joint inspection after reflow can be done with X-ray to monitor defects such as bridging, open circuits and voids.

#### 13.3.3 Rework

In general, rework is not recommended. By rework we mean the process of removing the chip from the substrate and replacing it with a new chip. If a chip is removed from the substrate, most solder balls of the chip will be damaged. In that case it is recommended not to re-use the chip again.

#### 32 kHz watch circuit with programmable output period and pulse width

Device removal can be done when the substrate is heated until it is certain that all solder joints are molten. The chip can then be carefully removed from the substrate without damaging the tracks and solder lands on the substrate. Removing the device must be done using plastic tweezers, because metal tweezers can damage the silicon. The surface of the substrate should be carefully cleaned and all solder and flux residues and/or underfill removed. When a new chip is placed on the substrate, use the flux process instead of solder on the solder lands. Apply flux on the bumps at the chip side as well as on the solder pads on the substrate. Place and align the new chip while viewing with a microscope. To reflow the solder, use the solder profile shown in application note *AN10365 "Surface mount reflow soldering description"*.

### 13.3.4 Cleaning

Cleaning can be done after reflow soldering.

### 32 kHz watch circuit with programmable output period and pulse width

### 14. Abbreviations

Table 17. Abbreviations

Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
FFC	Film Frame Carrier
НВМ	Human Body Model
IC	Integrated Circuit
LSB	Least Significant Bit
MM	Machine Model
MSB	Most Significant Bit
MSL	Moisture Sensitivity Level
OTP	One Time Programmable
PCB	Printed-Circuit Board
TEC	Thermal Expansion Coefficient
WLCSP	Wafer Level Chip-Size Package

### 15. References

- [1] AN10365 Surface mount reflow soldering description
- [2] AN10439 Wafer Level Chip Size Package
- [3] AN10706 Handling bare die
- [4] IEC 60134 Rating systems for electronic tubes and valves and analogous semiconductor devices
- [5] IEC 61340-5 Protection of electronic devices from electrostatic phenomena
- [6] JESD22-A114 Electrostatic Discharge (ESD) Sensitivity Testing Human Body Model (HBM)
- [7] **JESD22-A115** Electrostatic Discharge (ESD) Sensitivity Testing Machine Model (MM)
- [8] JESD78 IC Latch-Up Test
- [9] JESD625-A Requirements for Handling Electrostatic-Discharge-Sensitive (ESDS) Devices
- [10] NX3-00092 NXP store and transport requirements

# 32 kHz watch circuit with programmable output period and pulse width

# 16. Revision history

### Table 18. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
PCA2002 v.9	20191206	Product data sheet	-	PCA2002 v.8	
Modifications:	<ul> <li>Removed dis</li> </ul>	continued parts PCA2002CX8	3/5/1 and PCA2002CX	8/12/1	
	<ul> <li>Added PCA2002DUS/DA</li> </ul>				
PCA2002 v.8	20111125	Product data sheet	-	PCA2002 v.7	
Modifications:	<ul> <li>Added die ma</li> </ul>	arking codes			
PCA2002 v.7	20101005	Product data sheet		PCA2002_6	
PCA2002_6	20100506	Product data sheet	-	PCA2002_5	
PCA2002_5	20081111	Product data sheet	-	PCA2002_4	
PCA2002_4	20050907	Product data sheet	-	PCA2002_3	
PCA2002_3	20040120	Product specification	-	PCA2002_2	
PCA2002_2	20030204	Objective specification	-	PCA2002_1	
PCA2002_1	20021025	Objective specification	-	-	

**Product data sheet** 

#### 32 kHz watch circuit with programmable output period and pulse width

## 17. Legal information

#### 17.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="https://www.nxp.com">https://www.nxp.com</a>.

#### 17.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

**Product specification** — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

#### 17.3 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

**Applications** — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at <a href="http://www.nxp.com/profile/terms">http://www.nxp.com/profile/terms</a>, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

PCA2002

#### 32 kHz watch circuit with programmable output period and pulse width

**Export control** — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Non-automotive qualified products — Unless this data sheet expressly states that this specific NXP Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. NXP Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without NXP Semiconductors' warranty of the product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond NXP Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies NXP Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond NXP Semiconductors' standard warranty and NXP Semiconductors' product specifications.

Bare die — All die are tested on compliance with their related technical specifications as stated in this data sheet up to the point of wafer sawing and are handled in accordance with the NXP Semiconductors storage and transportation conditions. If there are data sheet limits not guaranteed, these will be separately indicated in the data sheet. There are no post-packing tests performed on individual die or wafers.

NXP Semiconductors has no control of third party procedures in the sawing, handling, packing or assembly of the die. Accordingly, NXP Semiconductors assumes no liability for device functionality or performance of the die or systems after third party sawing, handling, packing or assembly of the die. It is the responsibility of the customer to test and qualify their application in which the die is used.

All die sales are conditioned upon and subject to the customer entering into a written die sale agreement with NXP Semiconductors through its legal department.

#### 17.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

# 18. Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

### 32 kHz watch circuit with programmable output period and pulse width

### 19. Contents

1	General description	. 1
2	Features and benefits	. 1
3	Applications	. 1
4	Ordering information	. 2
4.1	Ordering options	. 2
5	Block diagram	. 3
6	Pinning information	
6.1	Pinning	
6.2	Pin description	
7	Functional description	
7.1	Motor pulse	
7.2	Time calibration	
7.3	Reset	. 7
7.4	Programming possibilities	. 7
7.5	Type recognition	
7.6	Programming procedure	
7.7	Programming the memory cells	
7.8	Checking the memory content	11
7.9	Frequency tuning at assembled watch	12
7.10	Measurement of the oscillator frequency and the	
_	inhibition time	12
8	Limiting values	14
9	Characteristics	15
10	OTP programming characteristics	16
10 11		16 17
	OTP programming characteristics	
11	OTP programming characteristics  Bare die outline	17
11 12	OTP programming characteristics  Bare die outline	17 19 19 20
<b>11 12</b> 12.1	OTP programming characteristics  Bare die outline  Packing information	17 19 19 20
11 12 12.1 12.2	OTP programming characteristics	17 19 19 20
11 12 12.1 12.2	OTP programming characteristics	17 19 19 20
11 12 12.1 12.2 12.3 13 13.1	OTP programming characteristics  Bare die outline	17 19 19 20 on.
11 12 12.1 12.2 12.3 13 13.1 13.2	OTP programming characteristics  Bare die outline	17 19 19 20 on. 24 24 24
11 12 12.1 12.2 12.3 13 13.1 13.2 13.3	OTP programming characteristics.  Bare die outline	17 19 19 20 on. 24 24 24 24
11 12 12.1 12.2 12.3 13 13.1 13.2 13.3 13.3	OTP programming characteristics.  Bare die outline	17 19 19 20 on. 24 24 24 24 25
11 12 12.1 12.2 12.3 13 13.1 13.2 13.3 13.3	OTP programming characteristics.  Bare die outline	17 19 19 20 on. 24 24 24 24 25 25
11 12 12.1 12.2 12.3 13 13.1 13.2 13.3 13.3	OTP programming characteristics.  Bare die outline	17 19 19 20 on. 24 24 24 25 25 25
11 12 12.1 12.2 12.3 13.1 13.2 13.3 13.3	OTP programming characteristics.  Bare die outline	17 19 19 20 on. 24 24 24 25 25 25 26
11 12 12.1 12.2 12.3 13 13.1 13.2 13.3 13.3	OTP programming characteristics.  Bare die outline	17 19 19 20 on. 24 24 24 25 25 25 26 27
11 12 12.1 12.2 12.3 13 13.1 13.2 13.3 13.3	OTP programming characteristics.  Bare die outline  Packing information  Tape and reel information  Tray information  Wafer and Film Frame Carrier (FFC) information  22  Soldering of WLCSP packages  Introduction to soldering WLCSP packages . Board mounting  Reflow soldering  Stand off  Quality of solder joint  Rework  Cleaning  Abbreviations  References	17 19 19 20 20 24 24 24 25 25 26 27
11 12 12.1 12.2 12.3 13 13.1 13.2 13.3 13.3	OTP programming characteristics.  Bare die outline  Packing information  Tape and reel information  Tray information  Wafer and Film Frame Carrier (FFC) information  22  Soldering of WLCSP packages.  Introduction to soldering WLCSP packages.  Board mounting  Reflow soldering.  Stand off.  Quality of solder joint  Rework  Cleaning.  Abbreviations.  References.  Revision history.	17 19 19 20 20 21 24 24 24 25 25 25 26 27 27
11 12 12.1 12.2 12.3 13 13.1 13.2 13.3 13.3	OTP programming characteristics.  Bare die outline  Packing information  Tape and reel information  Tray information  Wafer and Film Frame Carrier (FFC) information  22  Soldering of WLCSP packages.  Introduction to soldering WLCSP packages.  Board mounting  Reflow soldering  Stand off  Quality of solder joint  Rework  Cleaning  Abbreviations.  References  Revision history.  Legal information	17 19 19 20 20 24 24 24 25 25 25 27 27 28 29
11 12 12.1 12.2 12.3 13.1 13.2 13.3 13.3	OTP programming characteristics  Bare die outline  Packing information  Tape and reel information  Tray information  Wafer and Film Frame Carrier (FFC) information 22  Soldering of WLCSP packages  Introduction to soldering WLCSP packages  Board mounting  Reflow soldering  Stand off  Quality of solder joint  Rework  Cleaning  Abbreviations  References  Revision history  Legal information  Data sheet status	17 19 19 20 on. 24 24 24 25 25 25 26 27 27 28 29
11 12 12.1 12.2 12.3 13 13.1 13.2 13.3 13.3	OTP programming characteristics.  Bare die outline  Packing information  Tape and reel information  Tray information  Wafer and Film Frame Carrier (FFC) information  22  Soldering of WLCSP packages.  Introduction to soldering WLCSP packages.  Board mounting  Reflow soldering  Stand off  Quality of solder joint  Rework  Cleaning  Abbreviations.  References  Revision history.  Legal information	17 19 19 20 on. 24 24 24 25 25 25 27 27 28 29 29

17.4	Trademarks	30
18	Contact information	30
19	Contents	31

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© NXP B.V. 2019.

All rights reserved.